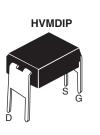
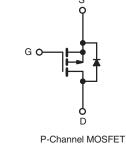


## **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	- 100				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V 0.60				
Q <sub>g</sub> (Max.) (nC)	18				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	9.0				
Configuration	Sing	le			





#### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

#### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertiable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION	
Package	HVMDIP
Lead (Pb)-free	IRFD9120PbF
Lead (Fb)-liee	SiHFD9120-E3
SnPb	IRFD9120
	SiHFD9120

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub>	= 25 °C, unless otherwis	se noted)			
PARAMETER			LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	- 100	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
Continuous Drain Current	$V_{GS} \text{ at - 10 V} \frac{T_A = 25 \text{ °C}}{T_A = 100 \text{ °C}}$	- I <sub>D</sub>	- 1.0		
	$T_A = 100 $ °C		- 0.70	А	
Pulsed Drain Current <sup>a</sup>			- 8.0		
Linear Derating Factor			0.0083	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	140	mJ	
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	- 1.0	А	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	0.13	mJ	
Maximum Power Dissipation $T_A = 25 \text{ °C}$		PD	1.3	W	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	*0	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	- °C	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD}$  = - 25 V, starting T<sub>J</sub> = 25 °C, L = 52 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = - 2.0 A (see fig. 12).

c.  $I_{SD} \leq$  - 6.8 A, dI/dt  $\leq$  110 A/µs,  $V_{DD} \leq V_{DS},\,T_J \leq$  175 °C.

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply



COMPLIANT

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	120	°C/W

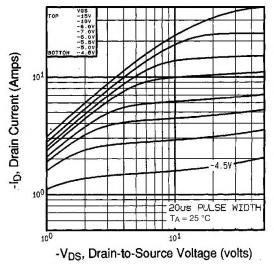
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		- -					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = - 250 μA	- 100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Referenc	e to 25 °C, I <sub>D</sub> = - 1 mA	-	- 0.10	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zara Cata Valtaga Drain Current		V <sub>DS</sub> =	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V		-	- 100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 80 <sup>v</sup>	V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	- 500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 0.6 A <sup>b</sup>	-	-	0.60	Ω
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub> = ·	- 50 V, I <sub>D</sub> = - 0.60 A <sup>b</sup>	0.71	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$		390	-	
Output Capacitance	Coss		$V_{DS} = -25 V$	-	170	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	t = 1.	f = 1.0 MHz, see fig. 5		45	-	1
Total Gate Charge	Qg		I <sub>D</sub> = - 6.8 A, V <sub>DS</sub> = - 80 V see fig. 6 and 13 <sup>b</sup>	-	-	18	nC
Gate-Source Charge	$Q_gs$	$V_{GS} = - 10 V$		-	-	3.0	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	9.0	
Turn-On Delay Time	t <sub>d(on)</sub>		$V_{DD}$ = - 50 V, I <sub>D</sub> = - 6.8 A R <sub>g</sub> = 18 Ω, R <sub>D</sub> = 7.1 Ω, see fig. 10 <sup>b</sup>		9.6	-	- ns
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =			29	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 18 \Omega,$			21	-	
Fall Time	t <sub>f</sub>				25	-	
Internal Drain Inductance	L <sub>D</sub>	6 mm (0.25") t	Between lead, 6 mm (0.25") from		4.0	-	24
Internal Source Inductance	L <sub>S</sub>	die contact		-	6.0	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	showing the			-	- 1.0	А
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	p - n junction diode		-	-	- 8.0	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C,	$T_J = 25 \text{ °C}, I_S = -1.0 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	- 6.3	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	− T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 6.8 A, dl/dt = 100 A/μs <sup>b</sup>		-	98	200	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.33	0.66	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and				L <sub>D</sub> )	

#### Notes

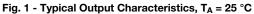
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



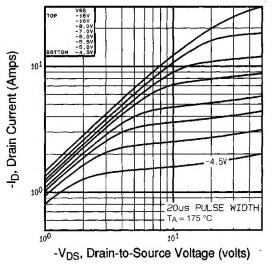
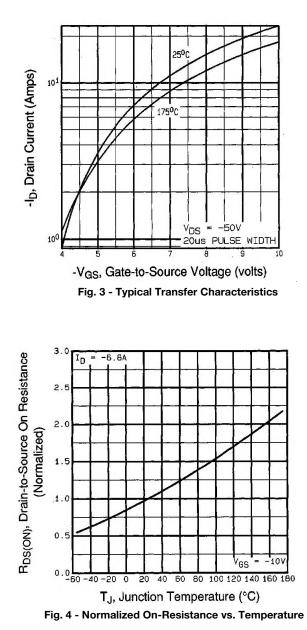


Fig. 2 - Typical Output Characteristics,  $T_A$  = 175  $^\circ\text{C}$ 



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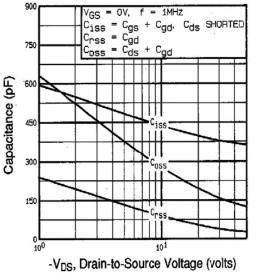
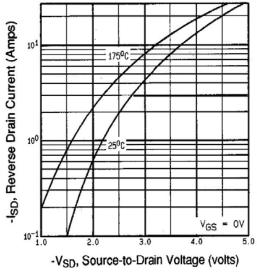


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





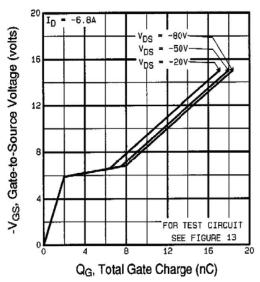
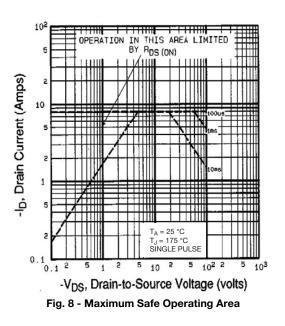


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





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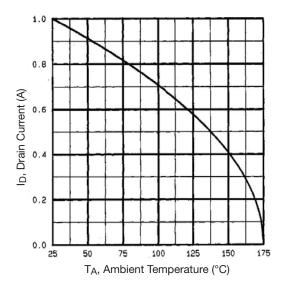


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

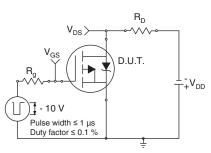


Fig. 10a - Switching Time Test Circuit

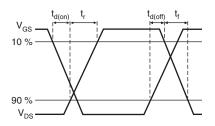


Fig. 10b - Switching Time Waveforms

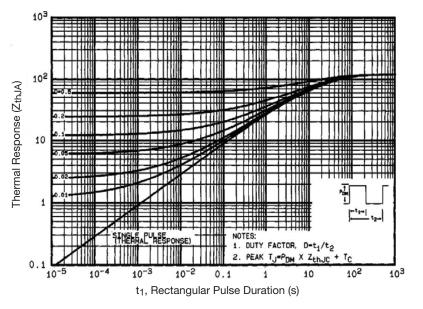


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



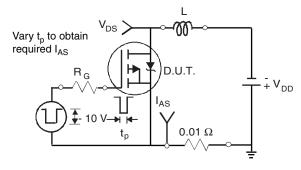


Fig. 12a - Unclamped Inductive Test Circuit

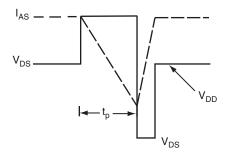


Fig. 12b - Unclamped Inductive Waveforms

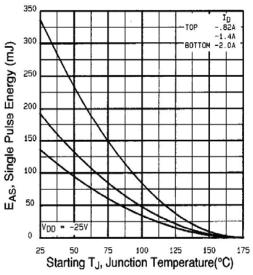
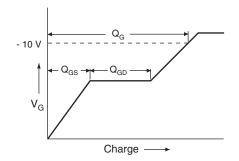


Fig. 12c - Maximum Avalanche Energy vs. Drain Current





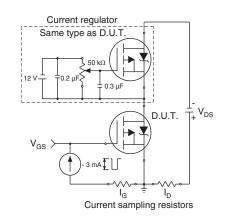
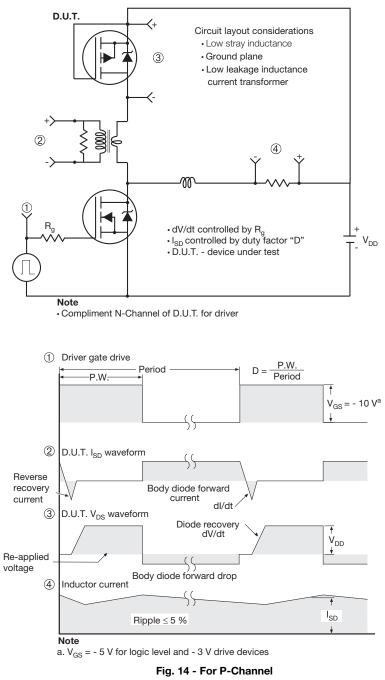


Fig. 13b - Gate Charge Test Circuit



#### **Vishay Siliconix**





Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?91139">www.vishay.com/ppg?91139</a>.



#### HVM DIP (High voltage)





	INC	INCHES		MILLIMETERS	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	0.310	0.330	7.87	8.38	
E	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	
ECN: X10-0386-Rev. B, 0 DWG: 5974	06-Sep-10				

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.



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